# Behaviors of thinned 2.5x2.5mm<sup>2</sup> sensors

26 Dec. 2006 T. Tsuboyama (KEK) Page 7: Revised: 27 Dec. Page 11:Erratum: 5 Jan 2007.

#### Thinned PIXEL and STRIP

 Done in
 On 21 Dec. 2006, I received the package.
 Package is OK.



#### The surface is dirty

#### The package is opened on 25 Dec. 2006.

#### **Evaluation is done as they are.**





## Quick result: I-V of strip

- K2400 source meter is connected to the sensor directly.
- The PN junction seems to be OK.
- Leak current is constant:
  - 0.06 nA/strip at Vb>-35 V.
- At Vb < -35 V, it takes 30 seconds for Ib to stabilize.
  - Break down voltage: -45V.



### Measurement by Miyake

Reported in 7 April meeting.

Sensor is not thinned.

Two 10 M resistors are put in series.

Leak current <0.05 nA/strip and gradually increases in 0>Vb>-60 V.

Breakdown voltage is 60 V.



# Summary on 25 Dec.

- Increase of leak current is not such bad as ATLAS SSD, reported by Kohriki (Dec. 2006)
- Breakdown voltage degrades from -60 V to -45 V after thinning.
  - Capacitance measurement is to be done.
- [ I am still optimistic about thinning.

We should try `thinning before dicing'.

#### 26 Dec. measurement

Set up is same as that of Miyake. est setud **Type 1 of the strip is measured.** Amplitude=0.1 V Agilent 4284A Freq.=1k, 10k, 100k and 1M 10MΩ 1000pF Capacitances are independently measured for type-5 and type-1 SOI Freq. 10KHz Level: 100mV

# 26 Dec. measurement (I-V)

- The tendency and absolute value is much similar to that measured by Miyake.
- Breakdown voltage is -45 V.
- The small fluctuations are due to long damping time of the bias current.



# 26 Dec. measurement (C-V)

- The capacitance behavior is also same as that of Miyake.
  The capacitance is still decreasing at 50 V.
  - The 100 µm-t substrate is not fully depleted at 50 V.





### Summary on 27 Dec.

- Breakdown voltage: 60 V before thinning, 45 V after thinning.
- Leak current does not increase: contrary to the 1000x increase observed in the thinned ATLAS strip detector.
  - Large amount of the current may flow to the detector edges.
    Need confirmation.
- Detector capacitance at given bias voltage is same.
  - The substrate seems not fully depleted at the breakdown voltage.

#### Erratum in 5 Jan 2007

I found the unit of I-V curve in Miyake's measurement is 1/10 than I thought. The I-V curves before and after the thinning are plotted here.

In summary, the leak current increased significantly in the thinning process.

